TSDxxC-Q1 Bidirectional TVS Diodes in SOD-323 Package for Automotive Applications

1 Features

- ISO 10605 (330pF, 330 Ohm) ESD protection:
  - ±30kV contact discharge (±27kV for TSD36C-Q1)
  - ±30kV air gap discharge
- IEC 61000-4-5 surge protection:
  - 6.5-15A (8/20 µs)
- Low IO capacitance < 7pF (typical)
- Ultra low leakage current: 10nA (maximum)
- Industrial temperature range: –55°C to +150°C
- Industry standard SOD-323 leaded package (2.65mm × 1.3mm)

2 Applications

- I/O Protection
- Power Line Protection
- USB VBUS
- Body Electronics & Lighting
- Hybrid, Electric, & Powertrain Systems

3 Description

The TSDxxC-Q1 are a family of bidirectional TVS protection diodes designed for clamping harmful transients such as ESD and surge in automotive applications. The TSDxxC-Q1 devices are rated to dissipate ESD strikes up to ±30kV (contact and air gap discharge) which exceeds the maximum level specified in the IEC 61000-4-2 international standard (Level 4).

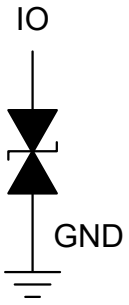
Combining the robust clamping performance and low capacitance of these devices, TSDxxC-Q1 are excellent TVS diodes to protect both data lines and power lines in many different applications.

The TSDxxC-Q1 family is offered in the industry standard, leaded SOD-323 package to enable easy solderability.

Package Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)
TSDxxC-Q1	DYF (SOD-323, 2)	2.65mm × 1.3mm

(1) For more information, see Section 10.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.



Functional Block Diagram

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Pin Configuration and Functions

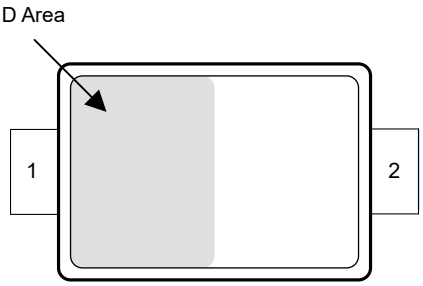


Figure 4-1. DYF Package, 2-Pin SOD-323 (Top View)

Table 4-1. Pin Functions

PIN		TYPE[1]	DESCRIPTION
NO.	NAME		
1	IO	I/O	Protected Channel. If used as IO, connect pin 2 to ground
2	IO	I/O	Protected Channel. If used as IO, connect pin 1 to ground

(1) I = input, O = output

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5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

Parameter		DEVICE	MIN	MAX	UNIT
P_{PP}	IEC 61000-4-5 (t_p 8/20µs) Peak Pulse Power at 25°C	TSD12C-Q1		390	W
		TSD15C-Q1			
		TSD18C-Q1			
		TSD24C-Q1			
		TSD36C-Q1		400	W
I_{PP}	IEC 61000-4-5 (t_p 8/20µs) Peak Pulse Current at 25°C	TSD12C-Q1		15	A
		TSD15C-Q1		12	A
		TSD18C-Q1			
		TSD24C-Q1		9	A
		TSD36C-Q1		6.5	A
T_A	Ambient Operating Temperature		-55	150	°C
T_{stg}	Storage Temperature		-65	155	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

5.2 ESD Ratings - AEC Specifications

Parameter		Test Conditions	VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per AEC Q101-001(1)	±2500	V
		Charged device model (CDM), per AEC Q101-005(2)	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 ESD Ratings—IEC Specification

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	IEC 61000-4-2 contact discharge	±30000	V
		IEC 61000-4-2 air-gap discharge	±30000	

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5.4 ESD Ratings - ISO Specifications

Parameter			Test Conditions	Device	VALUE	UNIT
$V_{(ESD)}$	ISO 10605 Electrostatic Discharge	Contact discharge, all pins	C = 150 pF; R = 330 Ω	TSD12C-Q1	±30000	V
				TSD15C-Q1		
				TSD18C-Q1		
				TSD24C-Q1		
				TSD36C-Q1		
			C = 330 pF; R = 330 Ω	TSD12C-Q1	±30000	V
				TSD15C-Q1		
				TSD18C-Q1		
				TSD24C-Q1		
				TSD36C-Q1	±27000	V
		Air-gap discharge, all pins	C = 150 pF; R = 330 Ω	TSD12C-Q1	±30000	V
				TSD15C-Q1		
				TSD18C-Q1		
				TSD24C-Q1		
				TSD36C-Q1		
			C = 330 pF; R = 330 Ω	TSD12C-Q1	±30000	V
				TSD15C-Q1		
				TSD18C-Q1		
				TSD24C-Q1		
				TSD36C-Q1		

5.5 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
T_A	Operating free-air temperature	-55		150	°C

5.6 Thermal Information

THERMAL METRIC		TSD12C-Q1 / TSD15C-Q1 / TSD18C-Q1	TSD24C-Q1 / TSD36C-Q1	UNIT
		DYF (SOD-323)	DYF (SOD-323)	
		2 PINS	2 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	683.8	686.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	264.2	267.0	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	559.0	560.5	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	89.9	91.4	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	544.8	546.2	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	N/A	°C/W

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5.7 Electrical Characteristics - TSD12C-Q1

At TA=25℃ (unless otherwise noted) (1)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} <10 nA, across operating temperature range			12	V
V_{BRR}	Breakdown voltage	I_{IO} = 10 mA, IO to GND and GND to IO	13.2	15.6	19	V
I_{LEAK}	Reverse leakage current	V_{IO} = 12 V, IO to GND or GND to IO		5	10	nA
V_{CLAMP}	Surge clamping voltage, t_p = 8/20 µs (2)	I_{PP} = 1 A, IO to GND or GND to IO			18.5	V
		I_{PP} = 5 A, IO to GND or GND to IO			21	V
		I_{PP} = 15 A, IO to GND or GND to IO			26	V
	TLP clamping voltage, t_p = 100 ns	I_{PP} = 16 A, IO to GND or GND to IO		19.4		V
R_{DYN}	Dynamic resistance(3)	IO to GND		0.15		Ω
		GND to IO				
C_L	Line capacitance	V_{IO} = 0 V; f = 1 MHz, IO to GND		6.5	8	pF

(1) Typical parameters are measured at 25℃
(2) Nonrepetitive current pulse 8 to 20 µs exponentially decaying waveform according to IEC 61000-4-5
(3) Extraction of R_{DYN} using least squares fit of TLP characteristics between I = 10 A and I = 20 A

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5.8 Electrical Characteristics - TSD15C-Q1

At TA=25℃ (unless otherwise noted) (1)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} <10 nA, across operating temperature range			15	V
V_{BRR}	Breakdown voltage	I_{IO} = 10 mA, IO to GND and GND to IO	19	22	25	V
I_{LEAK}	Reverse leakage current	V_{IO} = 15 V, IO to GND or GND to IO		5	10	nA
V_{CLAMP}	Surge clamping voltage, t_p = 8/20 µs (2)	I_{PP} = 1 A, IO to GND or GND to IO			25.6	V
		I_{PP} = 5 A, IO to GND or GND to IO			28	V
		I_{PP} = 12 A, IO to GND or GND to IO			33	V
	TLP clamping voltage, t_p = 100 ns	I_{PP} = 16 A, IO to GND or GND to IO		25		V
R_{DYN}	Dynamic resistance(3)	IO to GND		0.2		Ω
		GND to IO				
C_L	Line capacitance	V_{IO} = 0 V; f = 1 MHz, IO to GND		6.7	9	pF

(1) Typical parameters are measured at 25℃
(2) Nonrepetitive current pulse 8 to 20 µs exponentially decaying waveform according to IEC 61000-4-5
(3) Extraction of R_{DYN} using least squares fit of TLP characteristics between I = 10 A and I = 20 A

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5.9 Electrical Characteristics - TSD18C-Q1

At TA=25℃ (unless otherwise noted) (1)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} <10 nA, across operating temperature range			18	V
V_{BRR}	Breakdown voltage	I_{IO} = 10 mA, IO to GND and GND to IO	19	22	25	V
I_{LEAK}	Reverse leakage current	V_{IO} = 18 V, IO to GND or GND to IO		5	10	nA
V_{CLAMP}	Surge clamping voltage, t_p = 8/20 µs (2)	I_{PP} = 1 A, IO to GND or GND to IO			25.6	V
		I_{PP} = 5 A, IO to GND or GND to IO			28	V
		I_{PP} = 12 A, IO to GND or GND to IO			33	V
	TLP clamping voltage, t_p = 100 ns	I_{PP} = 16 A, IO to GND or GND to IO		25		V
R_{DYN}	Dynamic resistance(3)	IO to GND		0.2		Ω
		GND to IO				
C_L	Line capacitance	V_{IO} = 0 V; f = 1 MHz, IO to GND		6.7	9	pF

(1) Typical parameters are measured at 25℃
(2) Nonrepetitive current pulse 8 to 20 µs exponentially decaying waveform according to IEC 61000-4-5
(3) Extraction of R_{DYN} using least squares fit of TLP characteristics between I = 10 A and I = 20 A

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5.10 Electrical Characteristics - TSD24C-Q1

At TA=25℃ (unless otherwise noted) (1)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} <10 nA, across operating temperature range			24	V
V_{BR}	Breakdown voltage	I_{IO} = 10 mA, IO to GND and GND to IO	25.5	30.5	35.5	V
I_{LEAK}	Reverse leakage current	V_{IO} = 24 V, IO to GND or GND to IO		5	10	nA
V_{CLAMP}	Surge clamping voltage, t_p = 8/20 µs (2)	I_{PP} = 1 A, IO to GND or GND to IO			34	V
		I_{PP} = 5 A, IO to GND or GND to IO			43	V
		I_{PP} = 9 A, IO to GND or GND to IO			50	V
	TLP clamping voltage, t_p = 100 ns	I_{PP} = 16 A, IO to GND or GND to IO		36		V
R_{DYN}	Dynamic resistance(3)	IO to GND		0.35		Ω
		GND to IO				
C_L	Line capacitance	V_{IO} = 0 V; f = 1 MHz, IO to GND		4.3	6	pF

(1) Typical parameters are measured at 25℃
(2) Nonrepetitive current pulse 8 to 20 µs exponentially decaying waveform according to IEC 61000-4-5
(3) Extraction of R_{DYN} using least squares fit of TLP characteristics between I = 10 A and I = 20 A

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5.11 Electrical Characteristics - TSD36C-Q1

At TA=25℃ (unless otherwise noted) (1)

PARAMETER		TEST CONDITION	MIN	TYP	MAX	UNIT
V_{RWM}	Reverse stand-off voltage	I_{IO} <50 nA, across operating temperature range			36	V
V_{BR}	Breakdown voltage	I_{IO} = 10 mA, I/O to GND and GND to I/O	37.8	41.2	44.2	V
I_{LEAK}	Reverse leakage current	V_{IO} = 36 V, IO to GND or GND to IO		5	10	nA
V_{CLAMP}	Surge clamping voltage, t_p = 8/20 µs (2)	I_{PP} = 1 A, IO to GND or GND to IO			47	V
		I_{PP} = 5 A, IO to GND or GND to IO			64	V
		I_{PP} = 6.5 A, IO to GND or GND to IO			71	V
	TLP clamping voltage, t_p = 100 ns	I_{PP} = 16 A, IO to GND or GND to IO		56		V
R_{DYN}	Dynamic resistance (3)	IO to GND		0.6		Ω
		GND to IO				
C_L	Line capacitance	V_{IO} = 0 V; f = 1 MHz, IO to GND		4.3	6	pF

(1) Typical parameters are measured at 25℃
(2) Nonrepetitive current pulse 8 to 20 µs exponentially decaying waveform according to IEC 61000-4-5
(3) Extraction of RDYN using least squares fit of TLP characteristics between I = 10 A and I = 20 A

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5.12 Typical Characteristics

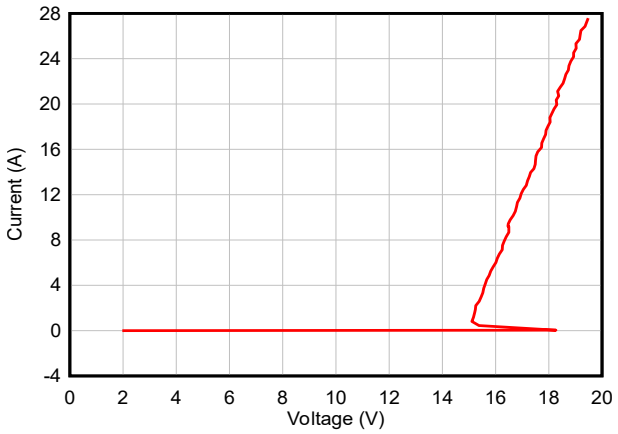


Figure 5-1. Positive TLP Curve - TSD12C-Q1

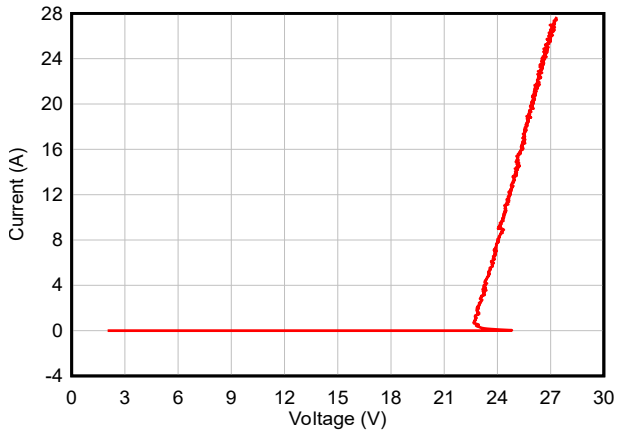


Figure 5-2. Positive TLP Curve - TSD15C-Q1

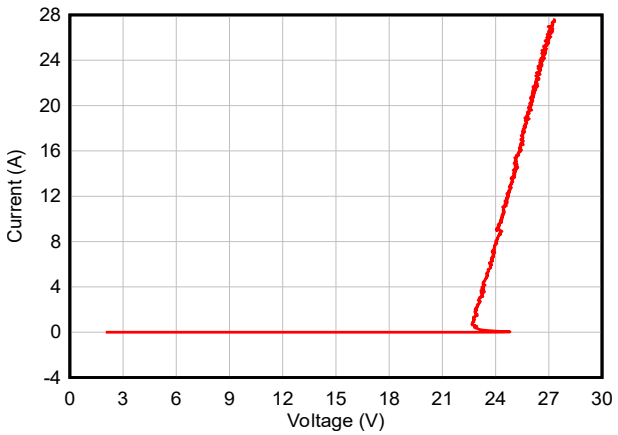


Figure 5-3. Positive TLP Curve - TSD18C-Q1

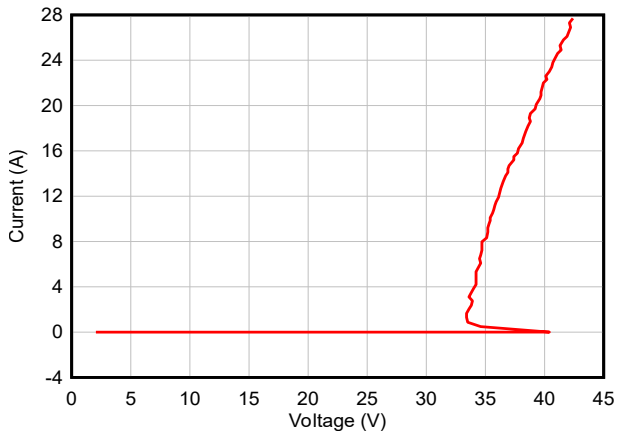


Figure 5-4. Positive TLP Curve - TSD24C-Q1

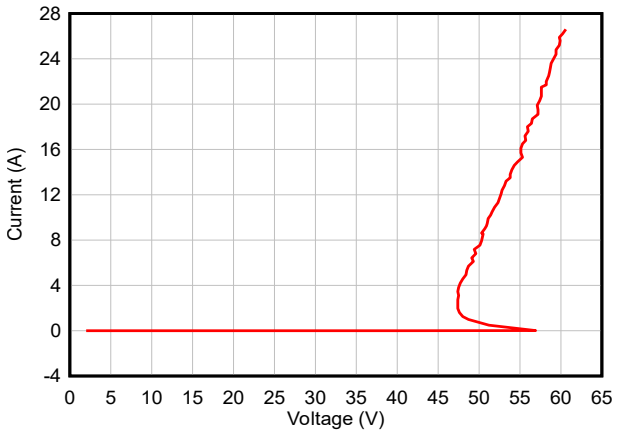


Figure 5-5. Positive TLP Curve - TSD36C-Q1

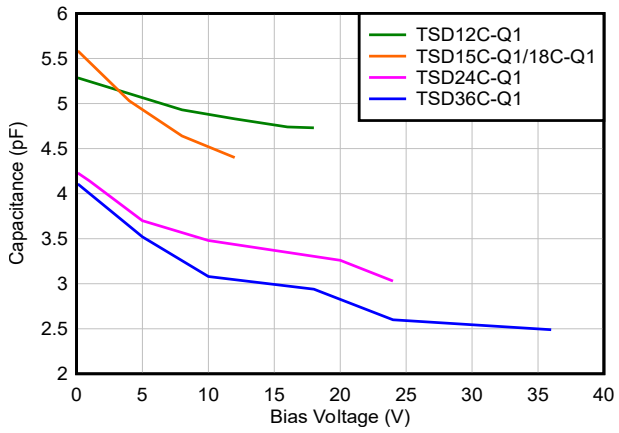


Figure 5-6. Capacitance vs Bias Voltage

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5.12 Typical Characteristics (continued)

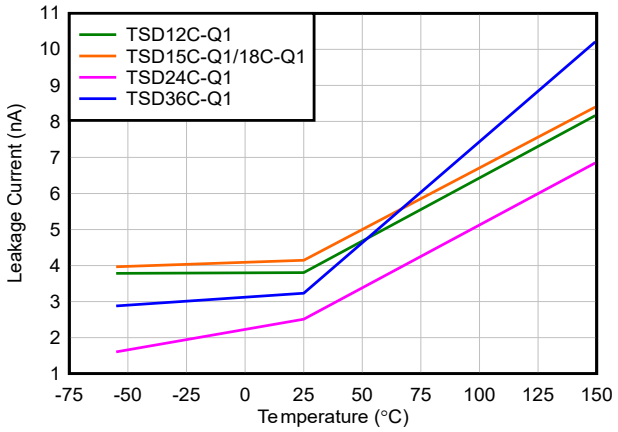


Figure 5-7. Leakage Current vs Temperature

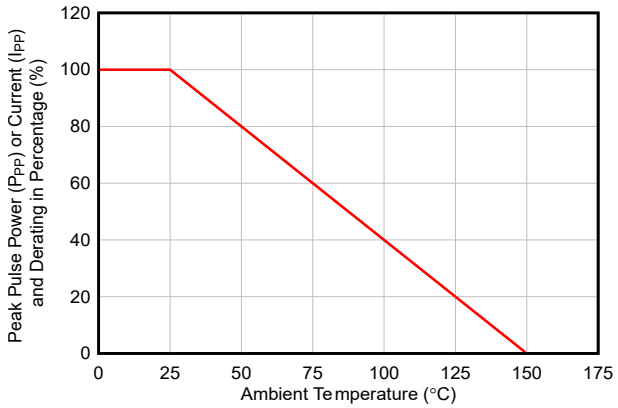


Figure 5-8. Peak Pulse Power Derating Curve

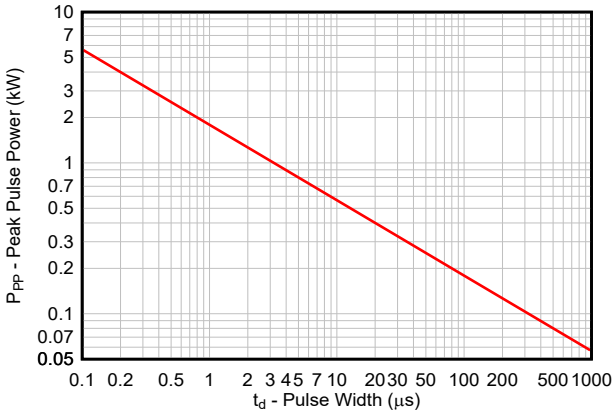


Figure 5-9. Pulse Power Rating Curve

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6 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

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7 Application Information

The TSDxxC-Q1 are TVS diodes that provide a path to ground for dissipating transient voltage spikes (such as ESD or surge) on signal lines and power lines. Connect the device in parallel to the down stream circuitry for protection. As the current from the transient passes through the TVS, only a small voltage drop is present across the diode. The small voltage drop is presented to the protected IC. The low R_{DYN} of the triggered TVS holds this voltage (V_{CLAMP}) to a safe level for the protected IC. For more information on how to properly use this device, refer to the *ESD Packaging and Layout Guide*.

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8 Device and Documentation Support

8.1 Documentation Support

8.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, *ESD Packaging and Layout Guide* application report
- Texas Instruments, *ESD Layout Guide* application report
- Texas Instruments, *Generic ESD Evaluation Module* user's guide
- Texas Instruments, *Reading and Understanding an ESD Protection Data Sheet* user's guide

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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8.4 Trademarks

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8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

TI Glossary — This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

DATE	REVISION	NOTES
October 2024	*	Initial Release

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TSD12CDYFRQ1	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-55 to 150	3JNF
TSD12CDYFRQ1.B	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	See TSD12CDYFRQ1	3JNF
TSD15CDYFRQ1	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-55 to 150	3MMF
TSD15CDYFRQ1.B	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	See TSD15CDYFRQ1	3MMF
TSD18CDYFRQ1	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-55 to 150	3JPF
TSD18CDYFRQ1.B	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	See TSD18CDYFRQ1	3JPF
TSD24CDYFRQ1	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-55 to 150	3GZF
TSD24CDYFRQ1.B	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	See TSD24CDYFRQ1	3GZF
TSD36CDYFRQ1	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	-55 to 150	3GPF
TSD36CDYFRQ1.B	Active	Production	SOT (DYF) | 2	3000 | LARGE T&R	Yes	SN	Level-3-260C-168 HR	See TSD36CDYFRQ1	3GPF

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative

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OTHER QUALIFIED VERSIONS OF TSD12C-Q1, TSD15C-Q1, TSD18C-Q1, TSD24C-Q1, TSD36C-Q1 :

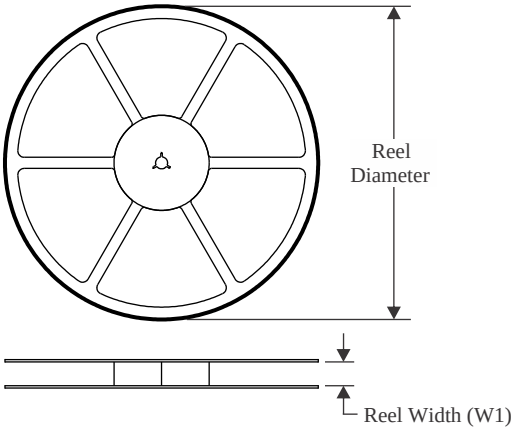
- Catalog : TSD12C, TSD15C, TSD18C, TSD24C, TSD36C

NOTE: Qualified Version Definitions:

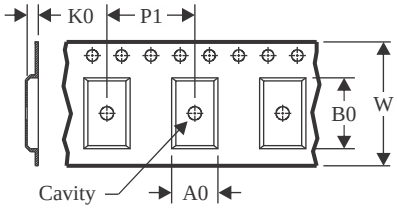
- Catalog - TI's standard catalog product

TAPE AND REEL INFORMATION

REEL DIMENSIONS

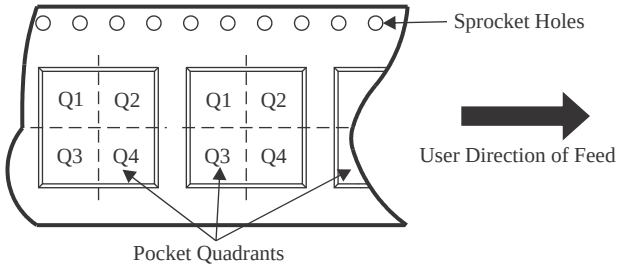


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

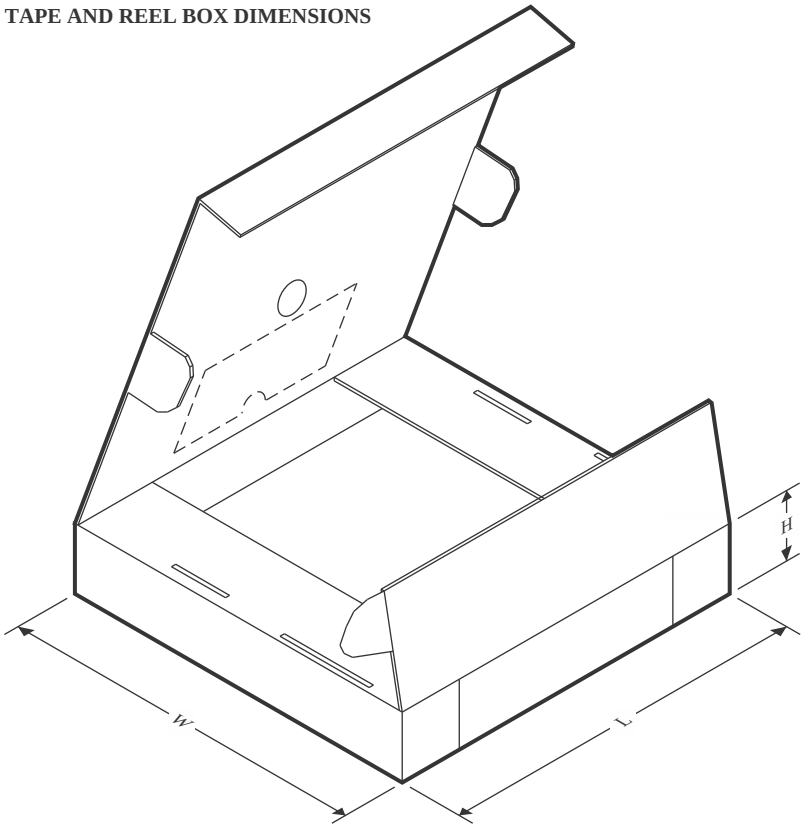
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TSD12CDYFRQ1	SOT	DYF	2	3000	178.0	9.5	1.48	3.3	1.25	4.0	8.0	Q1
TSD15CDYFRQ1	SOT	DYF	2	3000	178.0	9.5	1.48	3.3	1.25	4.0	8.0	Q1
TSD18CDYFRQ1	SOT	DYF	2	3000	178.0	9.5	1.48	3.3	1.25	4.0	8.0	Q1
TSD24CDYFRQ1	SOT	DYF	2	3000	178.0	9.5	1.48	3.3	1.25	4.0	8.0	Q1
TSD36CDYFRQ1	SOT	DYF	2	3000	178.0	9.5	1.48	3.3	1.25	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

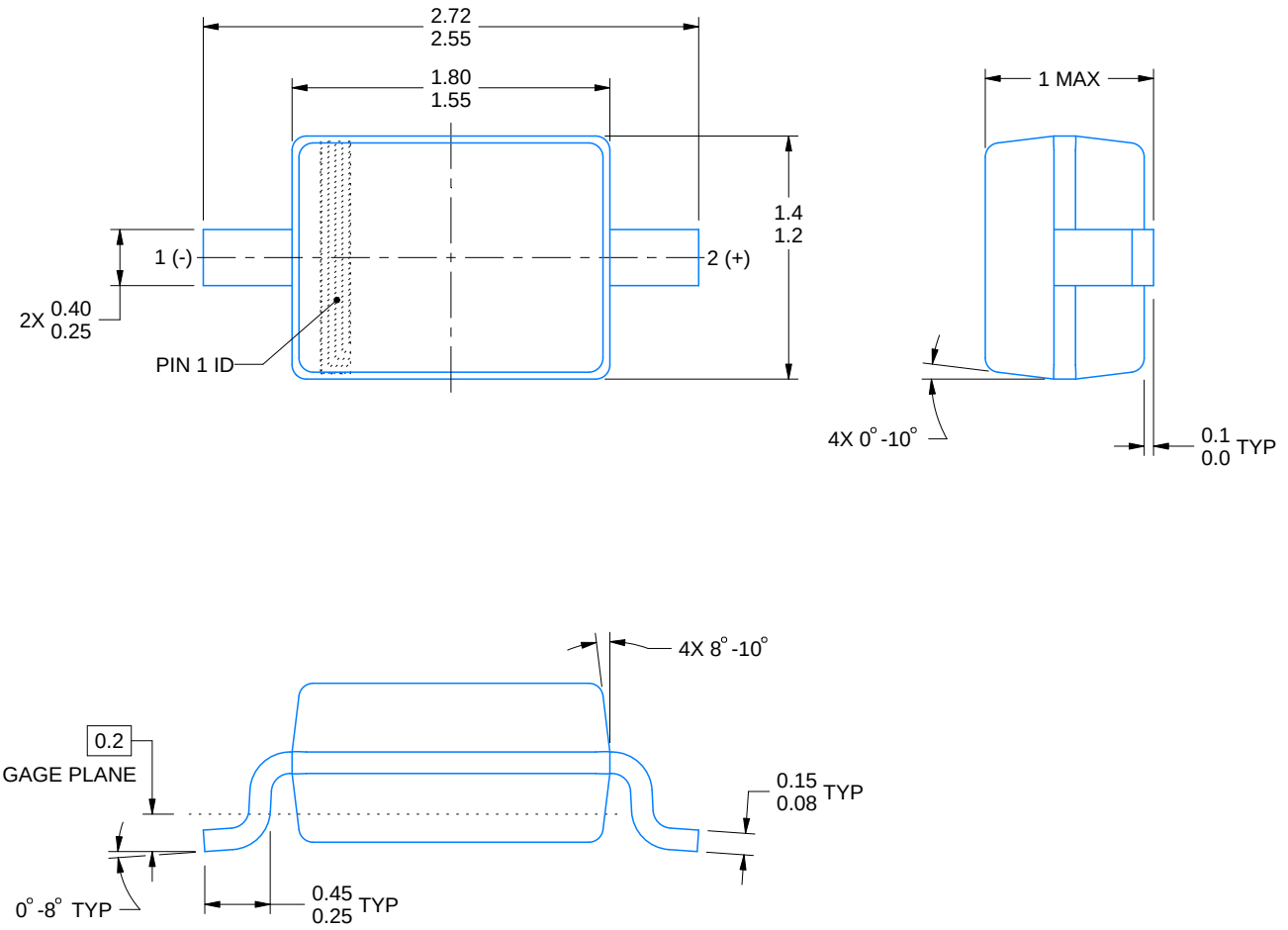
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TSD12CDYFRQ1	SOT	DYF	2	3000	210.0	200.0	42.0
TSD15CDYFRQ1	SOT	DYF	2	3000	210.0	200.0	42.0
TSD18CDYFRQ1	SOT	DYF	2	3000	210.0	200.0	42.0
TSD24CDYFRQ1	SOT	DYF	2	3000	210.0	200.0	42.0
TSD36CDYFRQ1	SOT	DYF	2	3000	210.0	200.0	42.0

PACKAGE OUTLINE

DYF0002A

SOT(SOD-323) - 1 mm max height

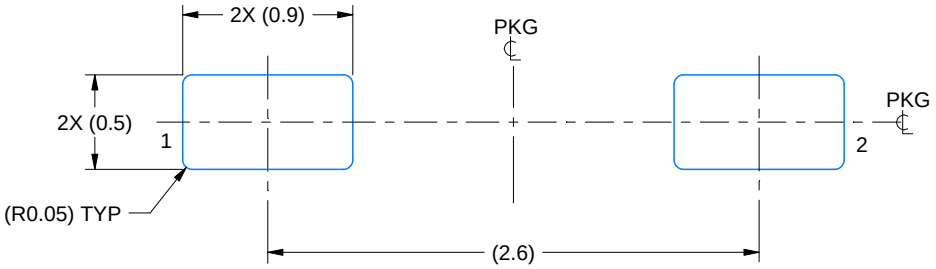
SMALL OUTLINE TRANSISTOR



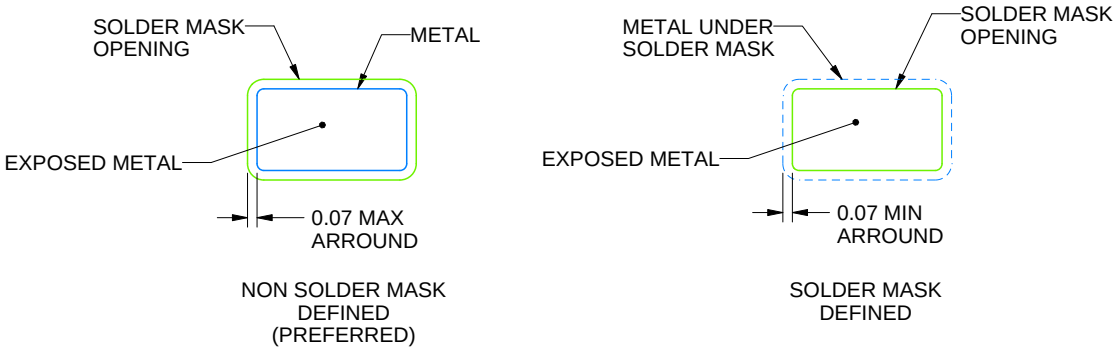
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NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:25X



SOLDER MASK DETAILS

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NOTES: (continued)

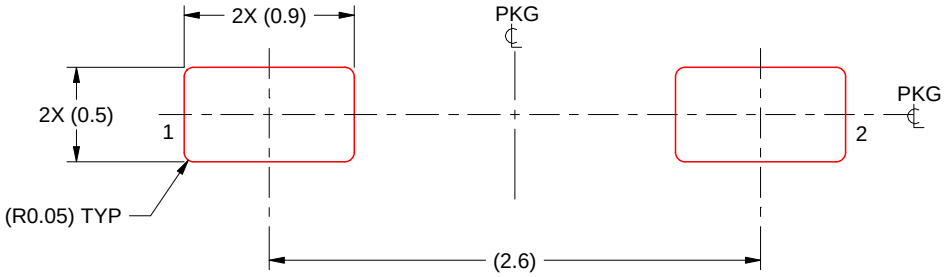
3. Publication IPC-7351 may have alternate designs.
4. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DYF0002A

SOT(SOD-323) - 1 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:25X

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NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
6. Board assembly site may have different recommendations for stencil design.

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